

**Search Notes**

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Examiner

Bin Shen

Applicant(s)/Patent under  
Reexamination

JALINK ET AL.

Art Unit

1657

**SEARCHED**

Class	Subclass	Date	Examiner
NA	NA	7/16/2007	BS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PubMed-see printout.	7/16/2007	BS
Priority document checked.	7/16/2007	BS
Inventor name searched.	7/16/2007	BS
SEQ search:NA.	7/16/2007	BS